SCBS665C - JUNE 1996 - REVISED JUNE 2004

- Members of the Texas Instruments
  Widebus™ Family
- Output Ports Have Equivalent 25-Ω Series Resistors, So No External Resistors Are Required
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  <0.8 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- High-Impedance State During Power Up and Power Down
- I<sub>off</sub> and Power-Up 3-State Support Hot Insertion
- Distributed V<sub>CC</sub> and GND Pins Minimize High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17

### description/ordering information

These 20-bit transparent D-type latches feature noninverting 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The 'ABT162841 devices can be used as two 10-bit latches or one 20-bit latch. While the latch-enable (1LE or 2LE) input is high, the Q outputs of the corresponding 10-bit latch follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the levels set up at the D inputs.

#### SN54ABT162841 . . . WD PACKAGE SN74ABT162841 . . . DGG OR DL PACKAGE (TOP VIEW)

			_	
1OE	1	O 56	3	1LE
1Q1	2	5	5 L	1D1
1Q2	3	54	4	1D2
GND	4	53	3	GND
1Q3	5	52	2	1D3
1Q4	6	5	1	1D4
v <sub>cc</sub> l	7	50	) [	$V_{CC}$
1Q5	8	49	9	1D5
1Q6	9	48	3	1D6
1Q7	10	4	7	1D7
GND	11	46	ŝ	GND
1Q8	12	4	5	1D8
1Q9	13	4	4	1D9
1Q10	14	43	3	1D10
2Q1	15	42	2	2D1
2Q2	16	4	1	2D2
2Q3	17	40	٦[	2D3
GND	18	39	9	GND
2Q4	19	38	3	2D4
2Q5	20	37	7	2D5
2Q6	21	36	ŝ	2D6
v <sub>cc</sub> [	22	3	5	$ v_{CC} $
2Q7	23	34	4 [	2D7
2Q8	24	33	3	2D8
GND	25	32	2	GND
2Q9	26	3	1 [	2D9
2Q10	27	30	0	2D10
2 <mark>OE</mark>	28	29	9[	2LE

### **ORDERING INFORMATION**

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	0000 01	Tube	SN74ABT162841DL	ADT400044
-40°C to 85°C	SSOP – DL	Tape and reel	SN74ABT162841DLR	ABT162841
	TSSOP - DGG	Tape and reel	SN74ABT162841DGGR	ABT162841
-55°C to 125°C	CFP – WD	Tube	SNJ54ABT162841WD	SNJ54ABT162841WD

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Widebus is a trademark of Texas Instruments.



SCBS665C - JUNE 1996 - REVISED JUNE 2004

### description/ordering information (continued)

A buffered output-enable (1 $\overline{\text{OE}}$  or 2 $\overline{\text{OE}}$ ) input can be used to place the outputs of the corresponding 10-bit latch in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly.

The outputs, which are designed to sink up to 12 mA, include equivalent 25- $\Omega$  series resistors to reduce overshoot and undershoot.

These devices are fully specified for hot-insertion applications using  $I_{off}$  and power-up 3-state. The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  shall be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

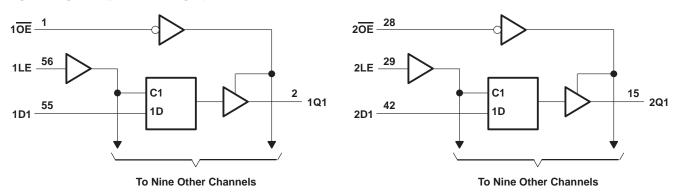
OE does not affect the internal operation of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

## FUNCTION TABLE (each 10-bit latch)

	INPUTS	OUTPUT	
OE	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	$Q_0$
Н	X	Χ	Z



## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high or power-off state, V <sub>O</sub>	
Current into any output in the low state, I <sub>O</sub>	30 mA
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–18 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DGG package	64°C/W
DL package	56°C/W
Storage temperature range, T <sub>stq</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

## recommended operating conditions (see Note 3)

			SN54ABT	162841	SN74ABT	162841	
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2	3	2		V	
V <sub>IL</sub>	Low-level input voltage		8.0		8.0	V	
VI	Input voltage	0 0	Vcc	0	VCC	V	
IOH	High-level output current		1	-3		-12	mA
l <sub>OL</sub>	Low-level output current		22	8		12	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled	30/	10		10	ns/V
Δt/ΔV <sub>CC</sub>	Power-up ramp rate		200		200	·	μs/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

SCBS665C - JUNE 1996 - REVISED JUNE 2004

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER		TEST SOUDITIONS		Т	A = 25°C	;	SN54ABT162841		SN74ABT162841		
"	ARAMETER	TEST CONDITIONS		MIN	TYP†	MAX	MIN	MAX	MIN	MAX	UNIT
VIK		$V_{CC} = 4.5 \text{ V},$	I <sub>I</sub> = -18 mA			-1.2		-1.2		-1.2	V
		$V_{CC} = 4.5 \text{ V},$	I <sub>OH</sub> = -1 mA	2.5			2.5		2.5		
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		$V_{CC} = 5 V$ ,	$I_{OH} = -1 \text{ mA}$	3			3		3		V
VOH		\/ 45\/	$I_{OH} = -3 \text{ mA}$	2.4			2.4		2.4		V
		V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -12 mA	2*					2		
.,		V 45V	I <sub>OL</sub> = 8 mA		0.4			0.8		0.65	V
VOL		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 12 mA		0.8*					0.8	V
V <sub>hys</sub>					100						mV
IJ		$V_{CC} = 0$ to 5.5 $V_I = V_{CC}$ or GN				±1		±1		±1	μА
lozpu	J	$V_{CC} = 0 \text{ to } 2.1 \text{ V},$ $V_{O} = 0.5 \text{ V to } 2.7 \text{ V}, \overline{\text{OE}} = X$				±50		±50		±50	μА
lozpc	)	$V_{CC} = 2.1 \text{ V to 0},$ $V_{O} = 0.5 \text{ V to 2.7 V, } \overline{OE} = X$				±50	, Q	±50		±50	μА
lozh		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$ $V_{O} = 2.7 \text{ V}, \overline{OE} \ge 2 \text{ V}$				10	2008	10		10	μА
lozL		V <sub>CC</sub> = 2.1 V to V <sub>O</sub> = 0.5 V, OE	5.5 V, ≥ 2 V			-10	Q	-10		-10	μА
loff		$V_{CC} = 0$ ,	$V_I$ or $V_O \le 4.5 \text{ V}$			±100				±100	μΑ
ICEX	Outputs high	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 5.5 V			50		50		50	μΑ
IO <sup>‡</sup>		$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 2.5 V	-25	-75	-100	-25	-100	-25	-100	mA
	Outputs high		_			0.5		0.5		0.5	
ICC	Outputs low	$V_{CC} = 5.5 \text{ V}, \text{ I}_{C}$ $V_{I} = V_{CC} \text{ or G}$				89		89		89	mA
	Outputs disabled	AL = ACC OLOUAD				0.5		0.5		0.5	
ΔlCC§		V <sub>CC</sub> = 5.5 V, O Other inputs at	ne input at 3.4 V, V <sub>CC</sub> or GND			1.5		1.5		1.5	mA
C <sub>i</sub>		$V_{I} = 2.5 \text{ V or } 0.$	5 V		3.5						pF
Co		$V_0 = 2.5 \text{ V or } 0$	).5 V		9						pF

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter does not apply.

## timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

		V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C	SN54ABT162841	SN74ABT162841	UNIT
		MIN MAX	MIN MAX	MIN MAX	
t <sub>W</sub>	Pulse duration, LE high or low	4	4	4	ns
t <sub>su</sub>	Setup time, data before LE↓	0.8	0.8	0.8	ns
th	Hold time, data after LE↓	1.8	1.8	1.8	ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ .

<sup>‡</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>§</sup> This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

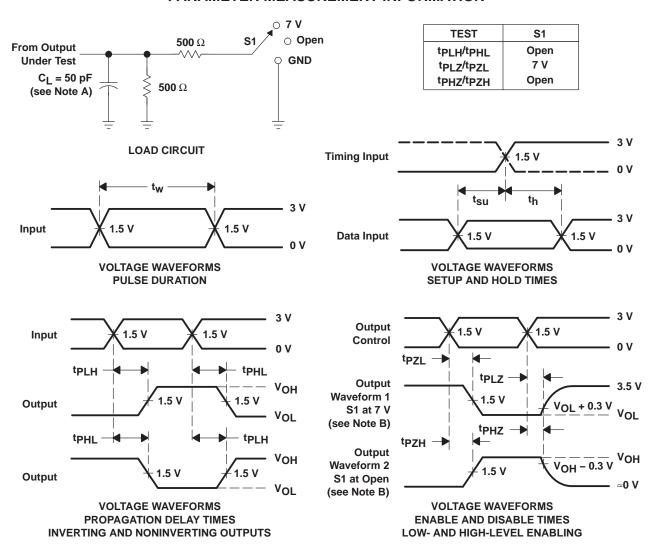
SCBS665C - JUNE 1996 - REVISED JUNE 2004

switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L$  = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			SN54ABT162841		SN74ABT162841		UNIT
	(INPUT)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>		_	2.1	3.5	4.5	2.1	5.7	2.1	5.2	
t <sub>PHL</sub>	D	Q	3	4.3	5.3	3	6.2	3	6	ns
<sup>t</sup> PLH		_	2.1	3.5	4.5	2.1	5.6	2.1	5.4	
t <sub>PHL</sub>	LE	Q	2.8	4.1	5.1	2.8	6.1	2.8	5.8	ns
<sup>t</sup> PZH	ŌĒ		2	3.6	4.7	2	5.8	2	5.7	
t <sub>PZL</sub>	OE	Q	3	4.6	5.7	83	6.7	3	6.5	ns
<sup>t</sup> PHZ	ŌĒ	Q	2.6	4.3	5.7	2.6	6.6	2.6	6.5	20
tPLZ	OE .	Q	2.2	3.6	5.8	2.2	8.4	2.2	7.1	ns

SCBS665C - JUNE 1996 - REVISED JUNE 2004

### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \,\Omega$ ,  $t_f \leq 2.5 \,$ ns,  $t_f \leq 2.5 \,$ ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms







.com 24-Feb-2006

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74ABT162841DGGRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ABT162841DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162841DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162841DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162841DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162841DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>&</sup>lt;sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

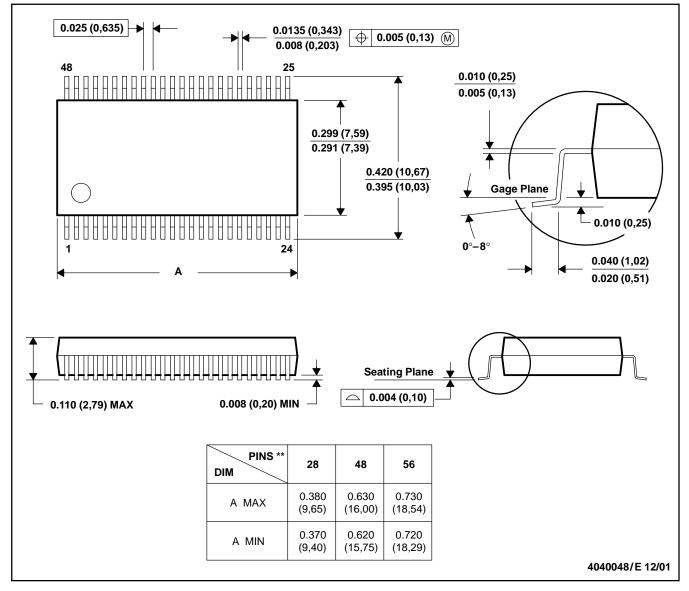
Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

### DL (R-PDSO-G\*\*)

### **48 PINS SHOWN**

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

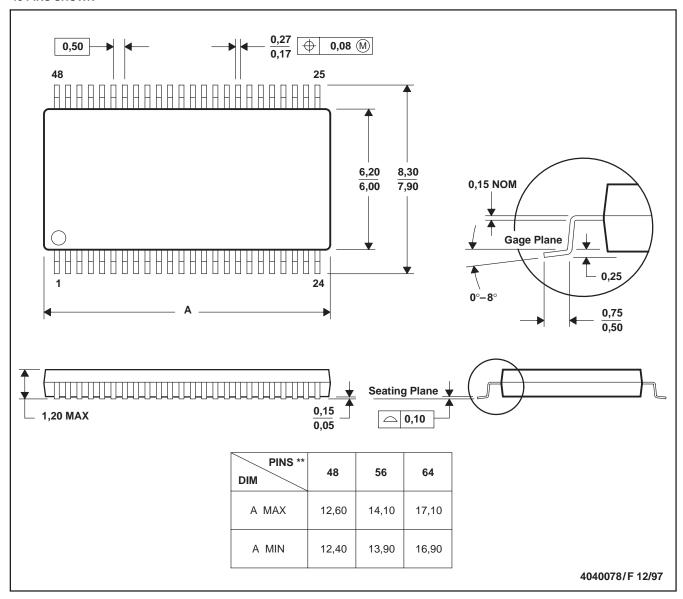
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

## DGG (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE PACKAGE

### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Interface	interface.ti.com	Digital Control	www.ti.com/digitalcontrol
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
		Telephony	www.ti.com/telephony
		Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

Copyright © 2006, Texas Instruments Incorporated